

Search Notes

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Examiner

Chau Nguyen

Applicant(s)/Patent under
Reexamination

KEMBEL ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	733	4/14/2006	CN
715	736	4/14/2006	CN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated Search on East Reports	4/13/2006	CN
	4/14/2006	CN
NPL Search on IEEE Database	4/14/2006	CN